Vacancy-Induced High Activity of MoS₂ Monolayer for CO Electroreduction: A

Computational Study

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Fig. S1. STM image simulation in the constant current mode under a bias voltage of - 0.5 V.



Fig. S2. Variation range of the formation energy (E_f) of $V_{S_1}V_{S2}$, V_{2S} and V_{3S_2} .



Fig. S3. The computed adsorption energies (E_{ads} , eV), distances between Mo and C atom (d_{Mo-C} , Å)



Fig. S4. The obtained free energy profiles of COR on (a) V_S , (b) V_{S2} and (c) V_{2S} .



Fig. S5. The involed COR intermediates on V_{3S} .

Elementary step	Free energy change (ΔG)
$CO(g) \rightarrow ^{*}CO$	-0.35
$^{*}CO + H^{+} + e^{-} \rightarrow ^{*}COH$	-0.26
$^{*}CO + H^{+} + e^{-} \rightarrow ^{*}CHO$	0.69
$*COH + H^+ + e^- \rightarrow *CHOH$	0.39
$^{*}\mathrm{COH} + \mathrm{H}^{+} + \mathrm{e}^{-} \rightarrow ^{*}\mathrm{C} + \mathrm{H}_{2}\mathrm{O}$	0.51
$^{*}\mathrm{CHOH} + \mathrm{H}^{+} + \mathrm{e}^{-} \rightarrow ^{*}\mathrm{CH} + \mathrm{H}_{2}\mathrm{O}$	-0.91
$^{*}\mathrm{CHOH} + \mathrm{H}^{+} + \mathrm{e}^{-} \rightarrow ^{*}\mathrm{CH}_{2}\mathrm{OH}$	1.01
$^{*}\mathrm{CH}_{2}\mathrm{OH} + \mathrm{H}^{+} + \mathrm{e}^{-} \rightarrow ^{*}\mathrm{CH}_{2} + \mathrm{H}_{2}\mathrm{O}$	-0.20
$^{*}\mathrm{CH}_{2}\mathrm{OH} + \mathrm{H}^{+} + \mathrm{e}^{-} \rightarrow \mathrm{CH}_{3}\mathrm{OH}^{*}$	-1.31
$^{*}\mathrm{CH}_{2} + \mathrm{H}^{+} + \mathrm{e}^{-} \rightarrow ^{*}\mathrm{CH}_{3}$	0.63
$^{*}\mathrm{CH}_{3}+\mathrm{H}^{+}+\mathrm{e}^{-}\!\rightarrow\mathrm{CH}_{4}\left(\mathrm{g}\right)$	-1.03

Table S1. The computed free energy changes of each possible elementary step duringthe electrochemical reduction of CO to CH_4 on the V_{38} monolayer.



Fig. S6. Gibbs free energy (ΔG) diagram for COR on V_{3S} with solvent effect.



Fig. S7. The considered structures of defective MoS_2 monolayers with different three S vacancies and the relative energy differences (ΔE), in which the line defect V_{3S} was employed as a reference, and the dotted lines represent S vacancy.



Fig. S8. The optimized adsorption configuration of (a) CO molecule and (b) H^* species on V_{3S} monolayer.



Fig. S9. The optimized adsorption configuration of H_2O molecule on V_{3S} monolayer.



Fig. S10. The computed transition state (T-s) for H_2O dissociation on hollow unsaturated Mo sites of the V_{3S} surface.



Fig. S11. The computed transition state (T-s) for CO hydroenation to COH^* via the Heyrovsky-type mechanism on the V_{3S} surface.